

**HN20P03****P-Channel 30-V (D-S) MOSFET**

General Description

These miniature surface mount MOSFETs utilize a high cell density trench process to provide low rDS(on) and to ensure minimal power loss and heat dissipation. Typical applications are DC-DC converters and power management in portable and battery-powered products such as computers, printers, PCMCIA cards, cellular and cordless telephones.

Features

- Advanced high cell density Trench technology
- Fast switching speed
- Lower On-resistance
- 100% EAS Guaranteed
- Simple Drive Requirement

Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	-30	V
V _{GS}	Gate-Source Voltage	±20	V
I _D @T _C =25°C	Continuous Drain Current	-20	A
I _D @T _C =100°C	Continuous Drain Current	-12	A
I _{DM}	Pulsed Drain Current ¹	-57	A
I _{AS}	Avalanche Current	-19	A
P _D @T _C =25°C	Total Power Dissipation ²	30	W
T _{STG}	Storage Temperature Range	-55 to 150	°C
T _J	Operating Junction Temperature Range	-55 to 150	°C

Thermal Data

Symbol	Parameter	Typ.	Max.	Unit
R _{θJA}	Thermal Resistance Junction-ambient ²	---	71.4	°C/W
R _{θJC}	Thermal Resistance Junction -Case	---	1.67	°C/W

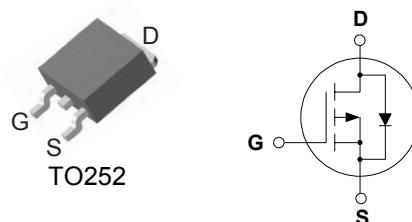
Product Summary

BVDSS	RDSON	ID
-30V	50mΩ	-20A

Applications

- DC-DC Converters
- Desktop PCs
- LED controller

TO252 Pin Configuration





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Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$, $I_D=-250\mu\text{A}$	-30	---	---	V
$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	BVDSS Temperature Coefficient	Reference to 25°C , $I_D=-250\mu\text{A}$	---	-15	---	$\text{mV}/^\circ\text{C}$
$R_{\text{DS(ON)}}$	Static Drain-Source On-Resistance	$V_{\text{GS}}=-10\text{V}$, $I_D=-10\text{A}$	---	---	50	$\text{m}\Omega$
		$V_{\text{GS}}=-4.5\text{V}$, $I_D=-5\text{A}$	---	---	90	
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}$, $I_D=-250\mu\text{A}$	-1	---	-3	V
$\Delta V_{\text{GS(th)}}$	$V_{\text{GS(th)}}$ Temperature Coefficient		---	4.0	---	$\text{mV}/^\circ\text{C}$
I_{DSS}	Drain-Source Leakage Current	$V_{\text{DS}}=-30\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=25^\circ\text{C}$	---	---	-10	uA
		$V_{\text{DS}}=-30\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=125^\circ\text{C}$	---	---	-100	
I_{GSS}	Gate-Source Leakage Current	$V_{\text{GS}}=\pm 20\text{V}$, $V_{\text{DS}}=0\text{V}$	---	---	± 100	nA
g_{fs}	Forward Transconductance	$V_{\text{DS}}=-8\text{V}$, $I_D=-9.5\text{A}$	---	6	---	S
Q_g	Total Gate Charge	$V_{\text{DS}}=-24\text{V}$, $V_{\text{GS}}=-5.0\text{V}$, $I_D=-19\text{A}$	---	15	21	nC
Q_{gs}	Gate-Source Charge		---	3.4	---	
Q_{gd}	Gate-Drain Charge		---	9.7	---	
$T_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{DD}}=-15\text{V}$, $V_{\text{GS}}=-5.0\text{V}$, $R_G=3.3\Omega$	---	16	---	ns
T_r	Rise Time		---	125	---	
$T_{\text{d(off)}}$	Turn-Off Delay Time		---	25	---	
T_f	Fall Time		---	68	---	
C_{iss}	Input Capacitance	$V_{\text{DS}}=-25\text{V}$, $V_{\text{GS}}=0\text{V}$, $f=1\text{MHz}$	---	750	---	pF
C_{oss}	Output Capacitance		---	345	---	
C_{rss}	Reverse Transfer Capacitance		---	110	---	

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I_s	Continuous Source Current	$V_G=V_D=0\text{V}$, Force Current	---	---	-20	A
I_{SM}	Pulsed Source Current		---	---	-57	A
V_{SD}	Diode Forward Voltage ³	$V_{\text{GS}}=0\text{V}$, $I_s=-19\text{A}$, $T_J=25^\circ\text{C}$	---	---	-3.4	V

Note :

- 1.Pulse width limited by Max. junction temperature.
- 2.When surface mounted to an FR-4 board using the 0.5 sq.in. drain pad size.
- 3.Reflects typical values. Cpk = Absolute Value of Spec (Spec-AVG/3.516 uA).